High voltage USB PD power switch

- ESD protection
 - ◆ IEC61000-4-2 contact discharge exceeds 8 kV on VBUS
 - ♦ HBM ANSI/ESDA/JEDEC JS-001 Class 2 exceeds 2 kV
 - ◆ CDM AEC standard Q100-01 (JESD22-C101E)
- Specified from -40 °C to +85 °C

3. Applications

- Smart and feature phones
- Tablets, eBooks
- Notebooks

4. Ordering information

Table 1. Ordering information

Type number	Package									
	Temperature range	Name	Description	Version						
NX20P5090UK	–40 °C to +85 °C	WLCSP15	wafer level chip-scale package; 15 bumps; 2.56 x 1.54 x 0.555 mm (Backside coating included)	SOT1392-1						

4.1 Ordering options

Table 2. Ordering options

Type number	Orderable part number	Package		Minimum order quantity	Temperature range
NX20P5090UK	NX20P5090UKAZ	WLCSP15	REEL 7" Q2/T3 *SPECIAL MARK CHIPS DP	3000	$T_{amb} = -40 ^{\circ}\text{C} \text{ to } +85 ^{\circ}\text{C}$

5. Marking

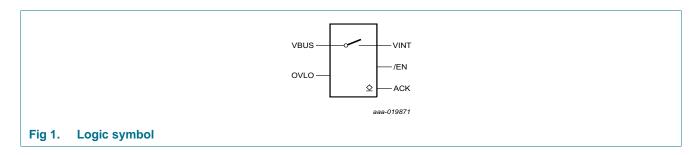
Table 3. Marking

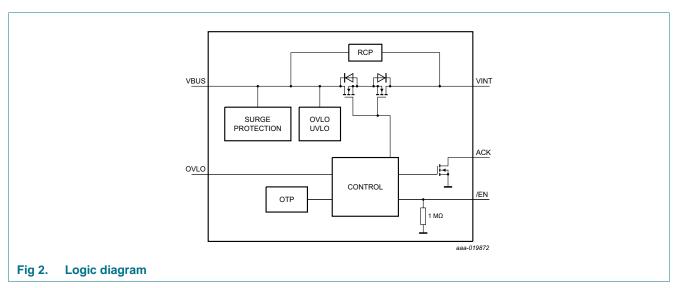
Line	Marking	Description	
A	X20PPD	basic type name	
В	mmmmmmnn	wafer lot code (mmmmmm) and wafer number (nn)	
С	ZtDYYWW	manufacturing code:	
		Z = foundry location	
		t = assembly location	
		D = RoHS code (dark green)	
		YY = assembly year code	
		WW = assembly week code	

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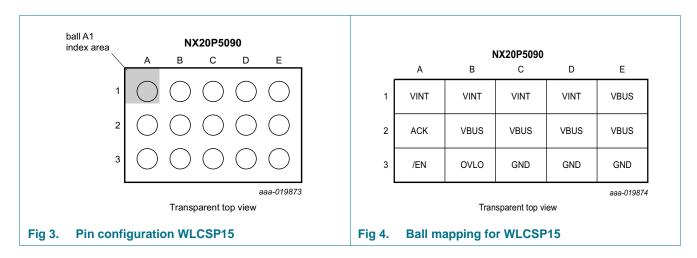
6. Functional diagram





7. Pinning information

7.1 Pinning



7.2 Pin description

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Product data sheet

High voltage USB PD power switch

Table 4. Pin description

Symbol	Pin	Description
VBUS	B2, C2, D2, E1, E2	VBUS (Power Input)
VINT	A1, B1, C1, D1	VINT (Power Output)
OVLO	B3	V _{OVLO} threshold input
ACK	A2	Power Good Acknowledge (open-drain output)
GND	C3, D3, E3	ground (0 V)
EN	A3	enable input (active LOW)

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High voltage USB PD power switch

8. Functional description

Table 5. Function table[1]

EN	VBUS	VINT	ACK	Operation mode
L	< 2.5 V	X	Z	Under-voltage lockout; switch open
L	2.5 V < VBUS < V _{OVLO}	X	L	Enabled; switch closed; charging mode
L	X	X	Z	Over-temperature protection; switch open
L	> V _{OVLO}	X	Z	Over-voltage lockout; switch open
Н	X	X	Z	Disable; switch open
X	X	VINT>VBUS	Z	Reverse Current Protection; Switch open

^[1] H = HIGH voltage level; L = LOW voltage level, Z = high-impedance OFF-state.

8.1 EN-input

A HIGH on \overline{EN} disables the channel MOSFET and all protection circuits, putting the device into low power mode. A LOW on \overline{EN} enables the protection circuits and the MOSFET. There is an internal 1 M Ω pull-down resistor on the \overline{EN} pin to ensure the power switch conduction in a dead-battery situation. A 15 ms de-bounce time has been deployed before device turn-on. \overline{EN} pin has 29 V tolerance.

8.2 Under-voltage lockout

When $\overline{\text{EN}}$ is LOW and VBUS < V_{UVLO}, the Under-Voltage LockOut (UVLO) circuits disable the power MOSFET. Once VBUS exceeds V_{UVLO} and no other protection circuit is active, the channel MOSFET state is controlled by the $\overline{\text{EN}}$ pin.

8.3 Over-voltage lockout

When $\overline{\text{EN}}$ is LOW and VBUS > V_{OVLO}, the over-voltage lockout (OVLO) circuit disables the power MOSFET. Once VBUS drops below V_{OVLO} and no other protection circuit is active, the power MOSFET resumes operation.

OVLO pin is used to set the over-voltage threshold. The default over-voltage threshold is 23 V when OVLO pin shorts to GND. Connecting a resistor divider to the OVLO pin (see <u>Figure 5</u>) adjusts the over voltage threshold from 4 V to 23 V using <u>Equation 1</u>:

$$Vovlo = Vth(ovlo) \times (R1 + R2)/(R2) \tag{1}$$

When the voltage on OVLO pin is below 0.1 V, the device defaults to the 23 V OVP threshold.

8.4 Over-temperature protection

When EN is LOW and the device temperature exceeds 140 °C the Over-Temperature Protection (OTP) circuit disables the power MOSFET and sets the ACK output Hi-Z. Once the device temperature decreases below 115 °C and no other protection circuit is active, the state of the N-channel MOSFET is controlled by the EN pin again.

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High voltage USB PD power switch

8.5 ACK output

The ACK output is an open-drain output that requires an external pull-up resistor. The ACK pin indicates the state of the power switch. When no fault is detected and power switch is conducting, ACK goes output low, otherwise it stays at high impedance. The pull up resistor value is recommend to be 10 K Ω to 200 K Ω .

8.6 Reverse Current Protection

NX20P5090 has all time reverse current protection regardless of the $\overline{\text{EN}}$ logic level. Once the voltage on VINT is higher than VBUS for 45 mV, the RCP circuit is triggered after a 3.7ms de-glitch time. If the voltage gap is greater than 120 mV, RCP triggers immediately to switch off the power MOSFET.

During the start up de-glitch time, if the device detects the VINT voltage is higher than VBUS by 45 mV, the power MOSFET does not turn on.

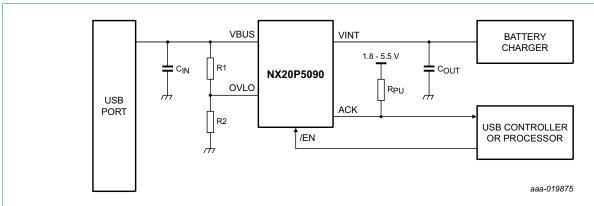
The RCP circuit helps by providing the capability of parallel connection of two USB charging ports to a single charger input, without backward leakage.

9. Application diagram

The NX20P5090 is typically used on a USB port charging path in a portable, battery operated device. The ACK signal requires an additional external pull-up resistor which should be connected to a supply voltage matching the logic input pin supply level that it is connected to.

When the default 23 V OVP threshold is used, the OVLO pin shorts to GND. If an adjustable OVP threshold is needed, a resister divider is connected to the OVLO pin.

For best performance, it is recommended to keep input and output traces short and capacitors as close to the device as possible. Regarding thermal performance, it is recommended to increase the PCB area around VINT and VBUS pins.



R1 and R2 are only needed for adjustable V_{OVLO} ; to use default V_{OVLO} threshold, connect OVLO to GND R1 is recommended to use minimum 1 M Ω resistor

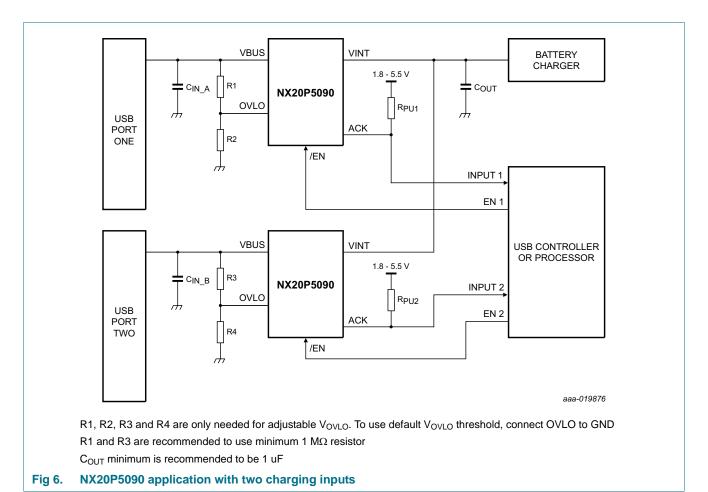
C_{OUT} minimum is recommended to be 1 uF

Fig 5. NX20P5090 application with one charging input

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High voltage USB PD power switch



10. Limiting values

Table 6. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
VI	input voltage	VBUS	[1]	-0.5	+29	V
		VINT	<u>[1]</u>	-0.5	+29	V
		OVLO		-0.5	VBUS	V
		EN	[2]	-0.5	+29	V
Vo	output voltage	ACK		-0.5	+6.0	V
I _{IK}	input clamping current	EN: V _I < −0.5 V		-50	-	mA
I _{SK}	switch clamping current	VBUS; VINT; V _I < -0.5 V		-50	-	mA
I _{SW}	continuous switch	T _{amb} = 85 °C		-	5	Α
	current	T _{amb} = 105 °C		-	3.5	Α
	peak switch current	100μs pulse, 2% duty cycle		-	10	Α
T _{stg}	storage temperature			-65	+150	°C
P _{tot}	total power dissipation	T _{amb} = 25 °C		-	1.45	W

^[1] The minimum and maximum switch voltage ratings may be exceeded if the switch clamping current rating is observed.

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High voltage USB PD power switch

[2] The minimum input voltage rating may be exceeded if the input current rating is observed.

11. Recommended operating conditions

Table 7. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Max	Unit
VI	input voltage	VBUS	2.5	20	V
		VINT	2.5	20	V
		EN	0	20	V
Vo	output voltage	ACK	0	5.5	V
T _{j(max)}	maximum junction temperature		-40	+125	°C
T _{amb}	ambient temperature		-40	+85	°C

12. Thermal characteristics

Table 8. Thermal characteristics

Symbol	Parameter	Conditions		Тур	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient		[1][2]	67.2	K/W

^[1] The overall Rth(j-a) can vary depending on the board layout. To minimize the effective Rth(j-a), all pins must have a solid connection to larger Cu layer areas e.g. to the power and ground layer. In multi-layer PCB applications, the second layer should be used to create a large heat spreader area right below the device. If this layer is either ground or power, it should be connected with several vias to the top layer connecting to the device ground or supply. Try not to use any solder-stop varnish under the chip.

^[2] This Rth(j-a) is calculated based on JEDEX2S2P board. The actual Rth(j-a) value may vary in applications using different layer stacks and layouts.

13. Static characteristics

Table 9. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

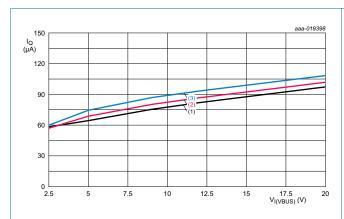
Symbol	Parameter	Conditions	T _{amb}	= 25 °C		$T_{amb} = -4$	0 °C to +85 °C	Unit
			Min	Тур	Max	Min	Max	
V_{IH}	HIGH-level input voltage	$\overline{\text{EN}}$ pin; $V_{\text{I(VBUS)}} = 2.5 \text{ V to } 20 \text{ V}$	1.2	-	-	1.2	-	V
V_{IL}	LOW-level input voltage	$\overline{\text{EN}}$ pin; $V_{\text{I(VBUS)}} = 2.5 \text{ V to } 20 \text{ V}$	-	-	0.4	-	0.4	V
V _{OL}	LOW-level output voltage	ACK; I_0 = 8 mA; $V_{I(VBUS)}$ = 2.5 V to 20 V	-	-	0.5	-	0.5	V
R _{pd}	pull-down resistance	EN	-	1	-	-	-	$M\Omega$
Iq	VBUS quiescent current	EN = 0 V; V _{I(VBUS)} = 5.0 V; I _O = 0 A;	-	70	-	-	95	μА
		$\overline{EN} = 0 \text{ V; } V_{I(VBUS)} = 20 \text{ V; } I_O = 0$ A;	-	100	-	-	140	μА
		EN = 5.0 V; V _{I(VBUS)} = 5.0 V; I _O = 0 A;	-	5	-	-	10	μА
		EN = 5.0 V; V _{I(VBUS)} = 20 V; I _O = 0 A;	-	15	-	-	30	μА
I _{S(OFF)}	VBUS OFF-state leakage current	$\overline{\text{EN}}$ = 5.0 V; V _{I(VBUS)} = 5.0 V; VINT = 0 V	-	5	-	-	10	μА
		EN = 5.0 V; V _{I(VBUS)} = 20 V; VINT = 0 V	-	15	-	-	30	μА
	VINT OFF-state Leakage current	EN = 5.0 V; V _{I(VINT)} = 5.0 V; VBUS = 0 V	-	1	-	-	5	μА
		EN = 5.0 V; V _{I(VINT)} = 20 V; VBUS = 0 V	-	4	-	-	16	μА
I _{S(ON)}	RCP leakage current	EN = 0 V; V _{I(VINT)} = 5 V; V _(VBUS) = 0 V	-	1	-	-	5	μА
l _l	OVLO input leakage Current	V _{OVLO} =V _{th(OVLO)}	-	-	-	-	50	nA
V _{UVLO}	under-voltage lockout release voltage	VBUS Rising; EN = 0 V	-	2.37	-	2.24	2.5	V
V _{hys(UVLO)}	under-voltage lockout hysteresis voltage	VBUS Falling	-	100	-	-	-	mV
V _{OVLO}	Default overvoltage lockout voltage	VBUS Rising; $\overline{EN} = 0 \text{ V; OVLO}$ short to GND	-	23	-	-	-	V
		VBUS Falling; $\overline{EN} = 0 \text{ V}$; OVLO short to GND	-	22.5	-	-	-	V
$V_{th(OVLO)}$	external OVLO set threshold voltage	$V_{I(VBUS)} = 2.5 \text{ V to } 20 \text{ V}; \overline{EN} = 0 \text{ V}$	-	1.227	-	1.164	1.287	V
V _{trig}	RCP trigger voltage	$V_{trig} = V_{(VINT)} - V_{(VBUS)}$	-	45	-	10	80	mV
Cı	input capacitance	EN pin; V _{I(VBUS)} = 5 V	-	4.5	-	-	-	pF

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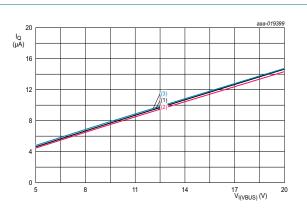
13.1 Graphs



$$\overline{\text{EN}} = 0 \text{ V}; I_{\text{O}} = 0 \text{ A}$$

- (1) $T_{amb} = +85 \, ^{\circ}C$.
- (2) $T_{amb} = +25 \, ^{\circ}C$.
- (3) $T_{amb} = -40 \, ^{\circ}C$.

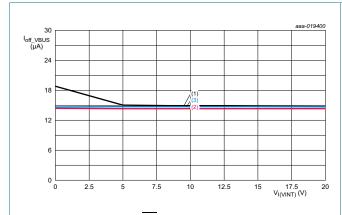
Fig 7. On-state quiescent current versus input voltage



$$\overline{\mathsf{EN}}$$
 = 5 V; I_O = 0 A

- (1) $T_{amb} = +85 \, ^{\circ}C$.
- (2) $T_{amb} = +25 \, ^{\circ}C$.
- (3) $T_{amb} = -40 \, ^{\circ}C$.

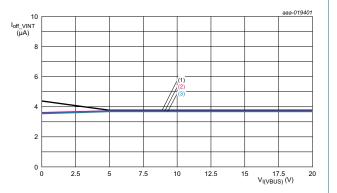
Fig 8. OFF-state quiescent current versus input voltage



 $V_{I(VBUS)} = 20 \text{ V}; \overline{EN} = 5 \text{ V}$

- (1) $T_{amb} = +85 \, ^{\circ}C$.
- (2) $T_{amb} = +25 \, ^{\circ}C$.
- (3) $T_{amb} = -40 \, ^{\circ}C$.

Fig 9. OFF-state leakage current on VBUS pin



 $V_{I(VINT)} = 20 \text{ V}; \overline{EN} = 5 \text{ V}$

- (1) $T_{amb} = +85 \, ^{\circ}C$.
- (2) $T_{amb} = +25 \, ^{\circ}C$.
- (3) $T_{amb} = -40 \, ^{\circ}C$.

Fig 10. OFF-state leakage current on VINT pin

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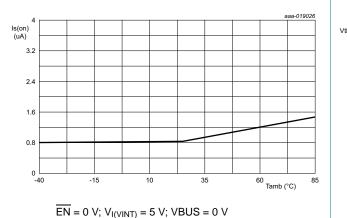
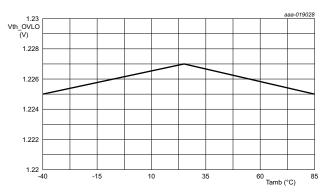


Fig 11. Reverse leakage current versus temperature



 $\overline{\text{EN}} = 0 \text{ V}; \text{ V}_{\text{I(VBUS)}} = 5 \text{ V}$

Fig 12. External OVLO set threshold versus temperature

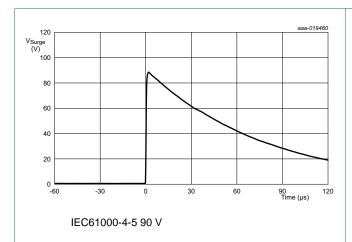
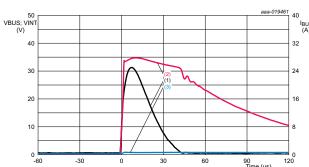


Fig 13. 90 V surge voltage without device

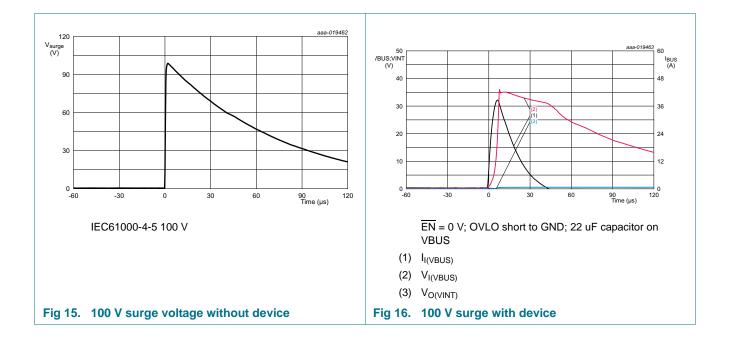


EN = 0 V; OVLO short to GND; no capacitor on VBUS

- (1) I_{I(VBUS)}
- (2) V_{I(VBUS)}
- (3) V_{O(VINT)}

Fig 14. 90 V surge with device

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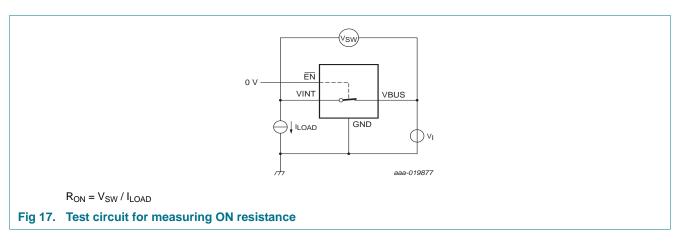
13.2 ON resistance

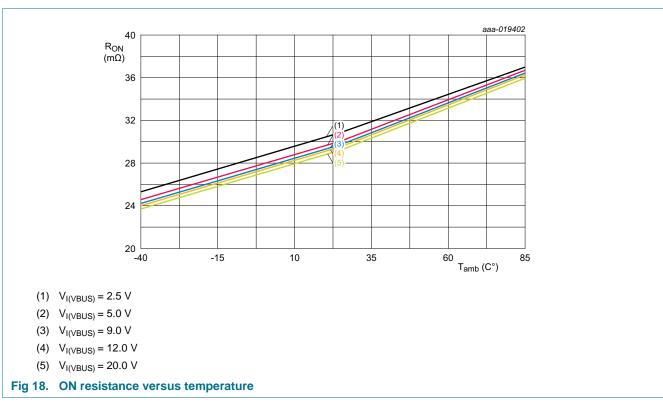
Table 10. ON resistance

At recommended operating conditions; voltages are referenced to GND (ground = 0 V)

Symbol	Parameter	Conditions		T _{amb} = 25 °C		$T_{amb} = -40 ^{\circ}\text{C} \text{ to } +85 ^{\circ}\text{C}$		Unit	
				Min	Тур	Max	Min	Max	
R _{ON}	ON resistance	I _{LOAD} = 1 A							
		V _{I(VBUS)} = 5.0 V		-	30	36	-	43	mΩ
		V _{I(VBUS)} = 20 V		-	30	36	-	43	mΩ

13.3 ON resistance test circuit and graphs





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High voltage USB PD power switch

14. Dynamic characteristics

Table 11. Dynamic characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for test circuit see Figure 20.

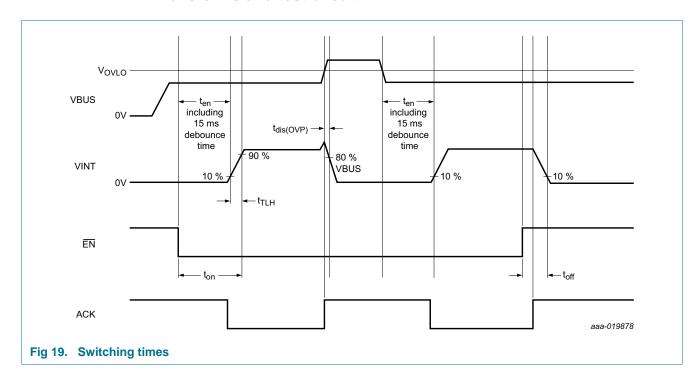
Symbol	Parameter Conditions		T,	amb =	= 25 °C		T _{amb} = -4	Unit	
				Min Typ		Max	Min	Max	
t _{en}	Enable Time	From $\overline{\text{EN}}$ to $V_{(VINT)}$ = 10% of $V_{(VBUS)}$; (Including 15ms debountime); $V_{I(VBUS)}$ = 5 V; C_{Load} = $100\mu\text{F}$; R_{Load} = 100Ω	ce -		21.9	-	-	-	ms
t _{TLH}	VINT rise time	$V_{(VINT)}$ from 10% to 90% $V_{(VBUS)}$ C_{Load} = 100 μ F; R_{Load} = 100 Ω	;						
		V _{I(VBUS)} = 5 V	-		3.4	-	-	-	ms
		V _{I(VBUS)} = 20 V	-		6.9	-	-	-	ms
t _{dis(OVP)}	OVP turn off time	From $V_{(VBUS)}$ > V_{ovlo} to $V_{(VINT)}$ = 80% of $V_{(VBUS)}$; R_{load} = 100 Ω ,; C_{load} = 0 μ F; $V_{I(VBUS)}$ = 20 V; OVLO pin short to GND			122	-	-	-	ns
t _{degl}	RCP de-glitch time	From V _(VINT) >V _(VBUS) +45mV to switch off	-		3.7	-	2.6	4.8	ms
t _{dis(RCP)}	RCP turn off time	From V _(VINT) >V _(VBUS) +120mV to switch off	[1] -		10	-	-	-	us
t _{on}	turn-on time	$\overline{\text{EN}}$ to $V_{\text{(VINT)}} = 90\% V_{\text{(VBUS)}}$							
		V _{I(VBUS)} = 5.0 V	-		25.3	-	-	-	ms
		V _{I(VBUS)} = 20 V	-		29.2	-	-	-	ms
t _{off}	turn-off time	EN to V _(VINT) = 10% V _(VBUS)							
		$V_{I(VBUS)} = 5.0 \text{ V; } C_{Load} = 100 \mu\text{F; } R_{Load} = 100 \Omega$	-		23	-	-	-	ms
		$V_{I(VBUS)}$ = 20 V; C_{Load} = 100 μ F; R_{Load} = 100 Ω	-		23	-	-	-	ms

[1] Guaranteed by design

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14.1 Waveforms and test circuit



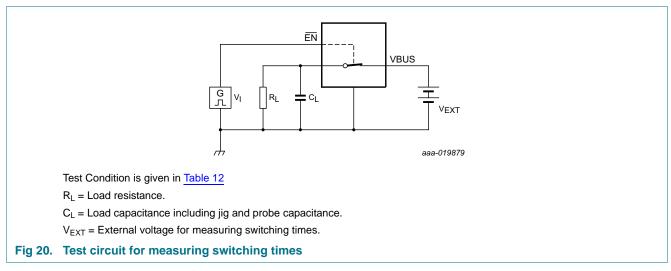
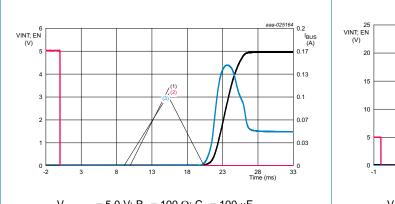


Table 12. Test Condition

Supply voltage V _{EXT}	Load					
VBUS	C _L R _L					
2.5 V to 20 V	100 μF	100 Ω				

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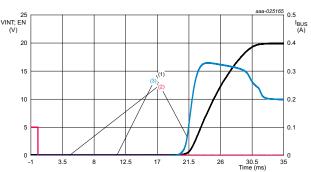
High voltage USB PD power switch



 $V_{I(VBUS)} = 5.0~V;~R_L = 100~\Omega;~C_L = 100~\mu F$

- (1) VINT
- (2) EN
- (3) I_{I(VBUS)}

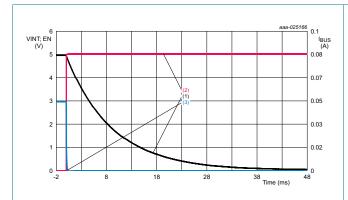
Fig 21. Turn on time and in-rush current at 5 V



 $V_{I(VBUS)} = 20.0 \ V; \ R_L = 100 \ \Omega; \ C_L = 100 \ \mu F$

- (1) VINT
- (2) EN
- (3) I_{I(VBUS)}

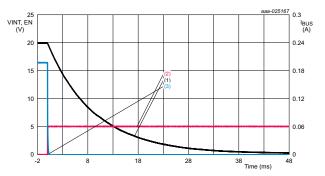
Fig 22. Turn on time and in-rush current at 20 V



 $V_{I(VBUS)} = 5.0~V;~R_L = 100~\Omega;~C_L = 100~\mu F$

- (1) VINT
- (2) EN
- (3) I_{I(VBUS)}

Fig 23. Turn off time at 5 V



 $V_{I(VBUS)} = 20.0 \; V; \; R_L = 100 \; \Omega; \; C_L = 100 \; \mu F$

- (1) VINT
- (2) EN
- (3) I_{I(VBUS)}

Fig 24. Turn off time at 20 V

High voltage USB PD power switch

15. Package outline

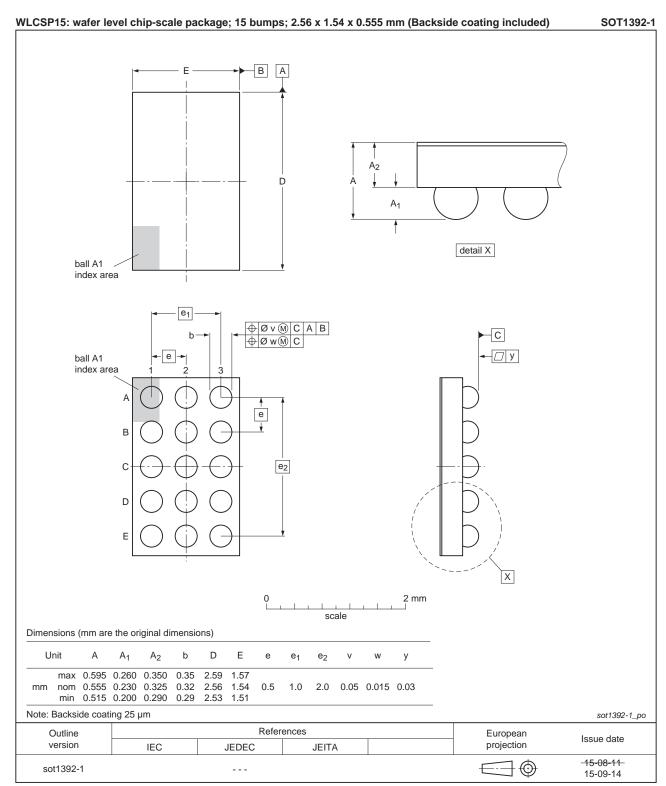


Fig 25. Package outline SOT1392-1 (WLCSP15)

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High voltage USB PD power switch

16. Packing information

16.1 Packing method

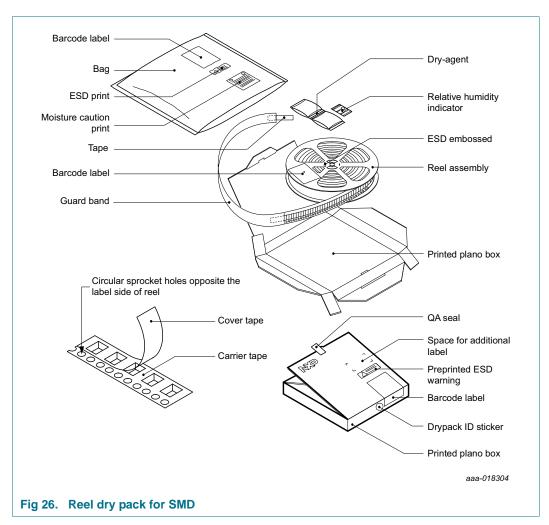


Table 13. Dimensions and quantities

	SPQ/PQ (pcs) [2]		Outer box dimensions I × w × h (mm)
180 × 12	3000	1	$209\times206\times37$

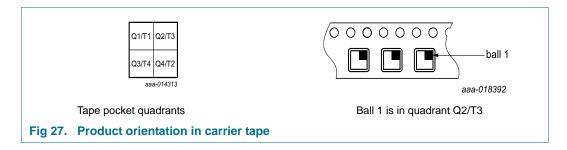
^[1] d = reel diameter; w = tape width.

^[2] Packing quantity dependent on specific product type.

View ordering and availability details at NXP order portal, or contact your local NXP representative.

High voltage USB PD power switch

16.2 Product orientation



16.3 Carrier tape dimensions

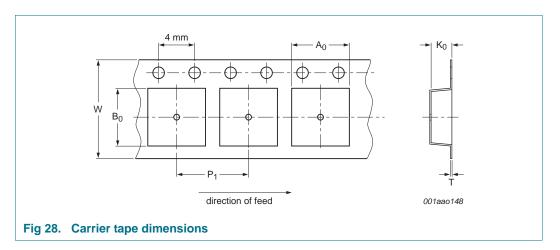


Table 14. Carrier tape dimensions

In accordance with IEC 60286-3.

A ₀ (mm)	B ₀ (mm)	K ₀ (mm)	T (mm)	P ₁ (mm)	W (mm)
1.67 ± 0.05	2.69 ± 0.05	0.70 ± 0.05	0.25 ± 0.02	4.0 ± 0.1	12 + 0.3 / - 0.1

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16.4 Reel dimensions

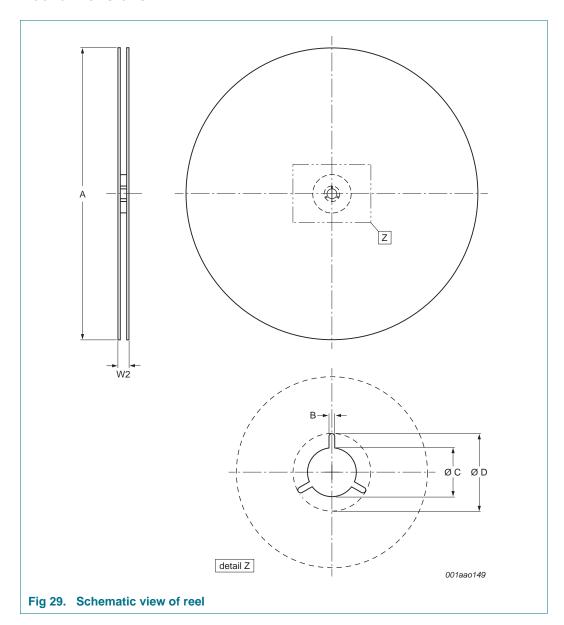


Table 15. Reel dimensions

In accordance with IEC 60286-3.

A [nom]	W2 [max]	B [min]	C [min]	D [min]
(mm)	(mm)	(mm)	(mm)	(mm)
180	18.4	1.5	12.8	20.2

High voltage USB PD power switch

16.5 Barcode label

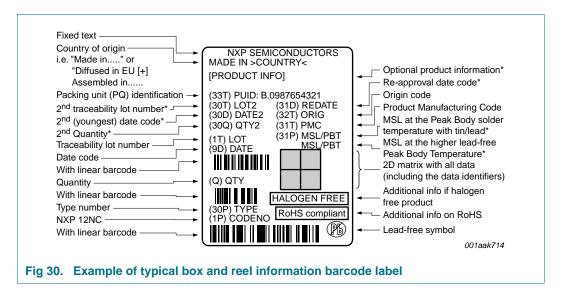


Table 16. Barcode label dimensions

	Reel barcode label I × w (mm)
100 × 75	100 × 75

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17. Soldering of WLCSP packages

17.1 Introduction to soldering WLCSP packages

This text provides a very brief insight into a complex technology. A more in-depth account of soldering WLCSP (Wafer Level Chip-Size Packages) can be found in application note AN10439 "Wafer Level Chip Scale Package" and in application note AN10365 "Surface mount reflow soldering description".

Wave soldering is not suitable for this package.

All NXP WLCSP packages are lead-free.

17.2 Board mounting

Board mounting of a WLCSP requires several steps:

- 1. Solder paste printing on the PCB
- 2. Component placement with a pick and place machine
- 3. The reflow soldering itself

17.3 Reflow soldering

Key characteristics in reflow soldering are:

- Lead-free versus SnPb soldering; note that a lead-free reflow process usually leads to higher minimum peak temperatures (see <u>Figure 31</u>) than a SnPb process, thus reducing the process window
- Solder paste printing issues, such as smearing, release, and adjusting the process window for a mix of large and small components on one board
- Reflow temperature profile; this profile includes preheat, reflow (in which the board is heated to the peak temperature), and cooling down. It is imperative that the peak temperature is high enough for the solder to make reliable solder joints (a solder paste characteristic) while being low enough that the packages and/or boards are not damaged. The peak temperature of the package depends on package thickness and volume and is classified in accordance with Table 17.

Table 17. Lead-free process (from J-STD-020D)

Package thickness (mm)	Package reflow temperature (°C)			
	Volume (mm³)			
	< 350	350 to 2000	> 2000	
< 1.6	260	260	260	
1.6 to 2.5	260	250	245	
> 2.5	250	245	245	

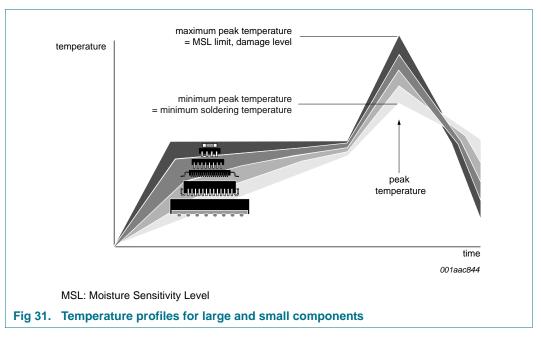
Moisture sensitivity precautions, as indicated on the packing, must be respected at all times.

Studies have shown that small packages reach higher temperatures during reflow soldering, see Figure 31.

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For further information on temperature profiles, refer to application note *AN10365* "Surface mount reflow soldering description".

17.3.1 Stand off

The stand off between the substrate and the chip is determined by:

- The amount of printed solder on the substrate
- The size of the solder land on the substrate
- The bump height on the chip

The higher the stand off, the better the stresses are released due to TEC (Thermal Expansion Coefficient) differences between substrate and chip.

17.3.2 Quality of solder joint

A flip-chip joint is considered to be a good joint when the entire solder land has been wetted by the solder from the bump. The surface of the joint should be smooth and the shape symmetrical. The soldered joints on a chip should be uniform. Voids in the bumps after reflow can occur during the reflow process in bumps with high ratio of bump diameter to bump height, i.e. low bumps with large diameter. No failures have been found to be related to these voids. Solder joint inspection after reflow can be done with X-ray to monitor defects such as bridging, open circuits and voids.

17.3.3 Rework

In general, rework is not recommended. By rework we mean the process of removing the chip from the substrate and replacing it with a new chip. If a chip is removed from the substrate, most solder balls of the chip will be damaged. In that case it is recommended not to re-use the chip again.

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Device removal can be done when the substrate is heated until it is certain that all solder joints are molten. The chip can then be carefully removed from the substrate without damaging the tracks and solder lands on the substrate. Removing the device must be done using plastic tweezers, because metal tweezers can damage the silicon. The surface of the substrate should be carefully cleaned and all solder and flux residues and/or underfill removed. When a new chip is placed on the substrate, use the flux process instead of solder on the solder lands. Apply flux on the bumps at the chip side as well as on the solder pads on the substrate. Place and align the new chip while viewing with a microscope. To reflow the solder, use the solder profile shown in application note *AN10365 "Surface mount reflow soldering description"*.

17.3.4 Cleaning

Cleaning can be done after reflow soldering.

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18. Revision history

Table 18. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
NX20P5090 v.1	20161014	Product data sheet	-	-

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19. Legal information

19.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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- [2] The term 'short data sheet' is explained in section "Definitions"
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Date of release: 14 October 2016 Document identifier: NX20P5090